# Silicon P Channel DV–L MOS FET High Speed Power Switching

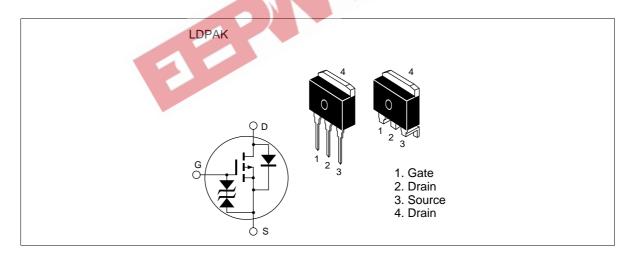
## **HITACHI**

ADE-208-541 1st. Edition

#### **Features**

- Low on-resistance  $R_{DS(on)} = 25 \text{ m}\Omega \text{ typ.}$
- 4V gate drive devices.
- High speed switching

#### **Outline**





#### **Absolute Maximum Ratings** (Ta = 25°C)

Item	Symbol	Ratings	Unit					
Drain to source voltage	$V_{\scriptscriptstyle DSS}$	-30	V					
Gate to source voltage	V <sub>GSS</sub>	±20	V					
Drain current	I <sub>D</sub>	-30	A					
Drain peak current	Note1 D(pulse)	-120	A					
Body to drain diode reverse drain current	I <sub>DR</sub>	-30	A					
Channel dissipation	Pch Note2	50	W					
Channel temperature	Tch	150	°C					
Storage temperature	Tstg	-55 to +150	°C					
Notes: 1. PW ≤ 10μs, duty cycle ≤ 1 % 2. Value at Tc = 25°C								



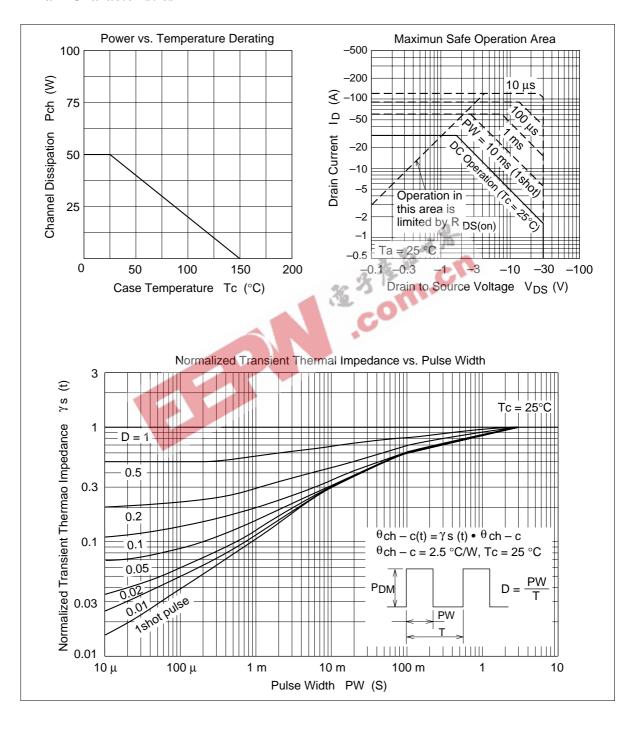
### **Electrical Characteristics** ( $Ta = 25^{\circ}C$ )

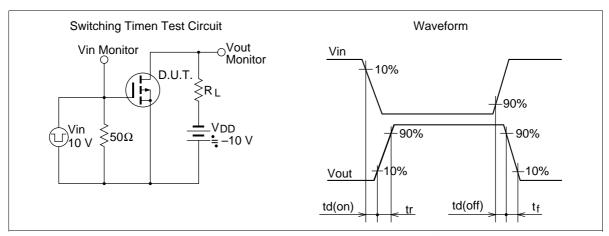
Item	Symbol	Min	Тур	Max	Unit	Test Conditions
Drain to source breakdown voltage	$V_{(BR)DSS}$	-30	_	_	V	$I_{D} = -10 \text{mA}, \ V_{GS} = 0$
Gate to source breakdown voltage	$V_{(BR)GSS}$	±20	_	_	V	$I_{G} = \pm 100 \mu A, V_{DS} = 0$
Zero gate voltege drain current	I <sub>DSS</sub>	_	_	-10	μΑ	$V_{DS} = -30 \text{ V}, V_{GS} = 0$
Gate to source leak current	I <sub>GSS</sub>	_	_	±10	μΑ	$V_{GS} = \pm 16V, V_{DS} = 0$
Gate to source cutoff voltage	$V_{GS(off)}$	-1.0	_	-2.0	V	$I_{D} = -1 \text{mA}, V_{DS} = -10 \text{V}$
Static drain to source on state	$R_{\rm DS(on)}$	_	25	35	m $Ω$	$I_D = -15A, V_{GS} = -10V^{Note3}$
resistance	R <sub>DS(on)</sub>	_	40	60	$m\Omega$	$I_{D} = -15A, V_{GS} = -4V^{Note3}$
Forward transfer admittance	$ y_{fs} $	12	20	_	S	$I_D = -15A, V_{DS} = -10V^{Note3}$
Input capacitance	Ciss	_	1700	-2. 4	pF	V <sub>DS</sub> = -10V
Output capacitance	Coss	_	950	大學	pF 🕝	$V_{GS} = 0$
Reverse transfer capacitance	Crss	- ,	260	-	pF	f = 1MHz
Turn-on delay time	t <sub>d(on)</sub>	-	20	GO.	ns	$V_{GS} = -10V, I_{D} = -15A$
Rise time	t,	74 1	290	_	ns	$R_L = 0.67\Omega$
Turn-off delay time	t <sub>d(off)</sub>	$\mathcal{F}$	170	_	ns	_
Fall time	t <sub>f</sub>		130	_	ns	_
Body to drain diode forward voltage	V <sub>DF</sub>	_	-1.1	_	V	$I_F = -30A, V_{GS} = 0$
Body to drain diode reverse recovery time	t <sub>m</sub>		70	_	ns	$I_F = -30A, V_{GS} = 0$ diF/ dt = 50A/ $\mu$ s

Note: 3. Pulse test

See characteristic curves of 2SJ471

#### **Main Characteristics**

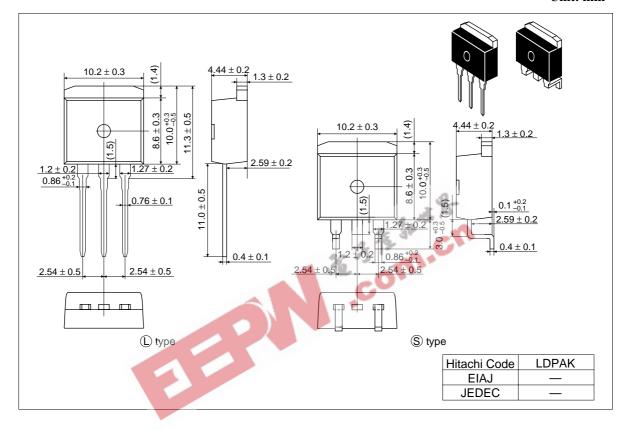






#### **Package Dimensions**

#### Unit: mm



#### **Cautions**

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